IEEE HOME | SEARCH IEEE | SHOP | WEB ACCOUNT | CONTACT IEEE

Standards

Publications/Services



	Xplore	្នាំ - - - - - - - - - - - - - - - - - - -	Welcome ates Patent and Tradema	ırk Office	
Help FAQ Terms I	EEE Peer Review	Quick Links			» Sea
Welcome to IEEE Xplore  - Home - What Can I Access? - Log-out Tables of Contents	Your searc A maximum Descendin Refine Th You may re	n of <b>500</b> results and order. is Search:		page, sorted by <b>Rel</b> e	
Journals & Magazines     Conference Proceedings     Standards	Check t	•		Search  STD = Standard	
Search  - By Author - Basic - Advanced - CrossRef	1 IEE Coll No.1994/	oquium on `New 149)	Microscopies in M	ledicine and Biology	y' (Dige
Member Services  - Join IEEE - Establish IEEE - Web Account - Access the - IEEE Member - Digital Library - Access the		, s. , an roat			

Print Format

IEEE Enterprise File Cabinet

Home | Log-out | Journals | Conference Proceedings | Standards | Search by Author | Basic Search | Advanced Search | Join IEEE | Web Account |
New this week | OPAC Linking Information | Your Feedback | Technical Support | Email Alerting | No Robots Please | Release Notes | IEEE Online |
Publications | Help | FAQ | Terms | Back to Top

Copyright © 2004 IEEE — All rights reserved

## Best Available Copy

IEEE HOME | SEARCH IEEE | SHOP | WEB ACCOUNT | CONTACT IEEE



JEES.	Welcome United States Patent and Trademark Office	11
Help FAQ Terms IEE	EE Peer Review Quick Links **	Sea
Welcome to IEEE Xplare*  - Home - What Can I Access? - Log-out	Your search matched 0 of 1134355 documents.  A maximum of 500 results are displayed, 15 to a page, sorted by Relevant Descending order.  Refine This Search:	ce
Tables of Contents  - Journals & Magazines	You may refine your search by editing the current search expression or entenew one in the text box.  (image < near/6> ((spm) or (scan* < near/2> probe < near/2> Search	erir
Conference Proceedings C-Standards	Check to search within this result set  Results Key:  JNL = Journal or Magazine CNF = Conference STD = Standard	
Search  - By Author - Basic - Advanced - CrossRef	Results: No documents matched your query.	
O- Join IEEE O- Establish IEEE Web Account O- Access the IEEE Member Digital Library		
O- Access the IEEE Enterprise File Cabinet		

Print Format

Home | Log-out | Journals | Conference Proceedings | Standards | Search by Author | Basic Search | Advanced Search | Join IEEE | Web Account |
New this week | OPAC Linking Information | Your Feedback | Technical Support | Email Alerting | No Robots Please | Release Notes | IEEE Online
Publications | Help | FAQ | Terms | Back to Top

Copyright © 2004 IEEE — All rights reserved